Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/549,376	FENN, DAVID
	Examiner	Art Unit	
	Louis K. Huynh	3721	

SEARCHED

Class	Subclass	Date	Examiner
53	329.3 372.6 374.8 374.9 375.6	7/11/2007	LH
53	477 485 486	7/11/2007	LH
53	487 289 290	7/11/2007	LH
Updated	All above	1/16/2008	LH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES
(INCLUDING SEARCH STRATEGY)

	DATE	EXMR